

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	1782	716/1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 14:51
S2	1540	716/2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 14:50
S3	1205	(716/19)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 14:51
S4	1	(716/1).ccls. and (yield adj enhancement)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 14:52
S5	4	(716/2).ccls. and (yield adj enhancement)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 14:54
S6	7	(716/19).ccls. and (yield adj enhancement)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 14:55
S7	33	("716"/\$).ccls. and (yield adj enhancement)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 14:55
S8	1544	(yield adj enhancement)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 14:56
S9	40	(yield adj enhancement) and (defect same substrate)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 14:56
S10	4	(yield adj enhancement) same (defect same substrate)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 15:03

S11	0	(yield adj enhancement) and (defect same substrate) and (database) and (design adj information)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 15:18
S12	0	(yield adj (maxim\$ or enhancement)) and (defect same substrate) and (database) and (design adj information)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 16:01
S13	0	(yield near (IC or (integrated adj circuit))) and (defect same substrate) and (database) and (design adj information)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 15:23
S14	3	(yield near (IC or (integrated adj circuit))) and (defect) and (database) and (design adj information)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 15:23
S15	8	(yield adj (maxim\$ or enhancement)) and (design adj information)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 17:13
S16	0	(yield adj (maxim\$ or enhancement)) and ((revis\$ or modify\$ or change) adj (design adj information))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/23 17:14
S17	4	(yield adj enhancement) adj data	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/04/01 18:33
S18	11	(yield adj enhancement) and (defect same substrate) and (database)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/07/12 13:21
S19	2	("6542830").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/07/12 13:21